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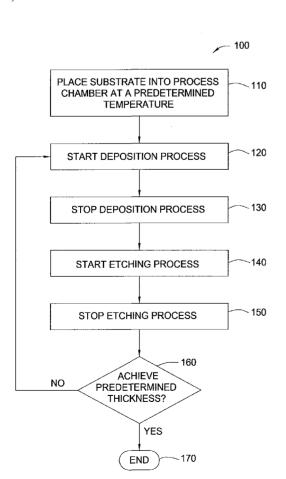
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(57) Abstract: A method for epitaxially forming a silicon-containing material on a substrate surface utilizes a halogen containing gas as both an etching gas as well as a carrier gas through adjustments of the process chamber temperature and pressure. It is beneficial to utilize HCl as the halogen containing gas because converting HCl from a carrier gas to an etching gas can easily be performed by adjusting the chamber pressure.



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B. FIELDS SEARCHED			
Minimum documentation searched (classification system followed by classification symbols)			
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Documentation searched other than minimum documentation to the extent that such documents are included in the fields searched pubWEST (DB=PGPB,USPT,USOC,EPAB,JPAB; PLUR=NO; OP=ADJ)			
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C. DOCUMENTS CONSIDERED TO BE RELEVANT			
Category*	Citation of document, with indication, where ap	propriate, of the relevant passages	Relevant to claim No.
Υ	US 2005/0079691 A1 (KIM et al.) 14 April 2005 (14.04. [0006]-[0013], [0023], [0044], [0018], [0021], [0009], [00	2005), entire document, especially para 010], [025], [0029], [0031], 0032], [0045],	1-36
Y	US 2006/0046442 A1 (RAMASWAMY) 02 March 2006 (02.03.2006), entire document, especially para [0039]		1-36
Υ	US 2003/0022528 A1 (TODD) 30 January 2003 (30.01.2003) see entire document, especially para [0047]		9, 10, 21 and 22
Α	US 2004/0259333 A1 (TOMASINI et al.) 23 December 2004 (23.12.2004), entire document		1-36
Further documents are listed in the continuation of Box C.			
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